

Notice of References Cited	Application/Control No. 10/517,360	Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner Phuongchi Nguyen	Art Unit 2833	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,958,852	05-1976	Abraham et al.	439/355
*	C	US-6,273,745	08-2001	Yeh, Jeff	439/404
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*	E	US-5,562,480	10-1996	Drewanz et al.	439/404
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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